

• General Description

The AGM12T12A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low R_{DS(ON)} to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

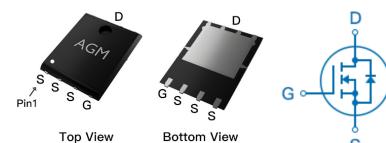
Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
120V	10mΩ	60A

PDFN5*6 Pin Configuration



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM12T12A	AGM12T12A	PDFN5*6	330mm	12mm	3000

Table 1. Absolute Maximum Ratings (TA=25℃)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	120	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25℃) (Note 1)	60	А
	Drain Current-Continuous(Tc=100°ℂ)	36	А
IDM (pluse)	Drain Current-Pulsed (Note 2)	240	А
PD	Maximum Power Dissipation(Tc=25℃)	33	W
	Maximum Power Dissipation(Tc=100℃)	13	w
EAS	Avalanche energy (Note 3)	110	mJ
TJ,TSTG	TJ,TSTG Operating Junction and Storage Temperature Range		$^{\circ}\!\mathbb{C}$

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
RθJA	Thermal Resistance Junction-ambient (Steady State) ¹		20	°C/W
RθJC	Thermal Resistance Junction-Case ¹		3.78	°C/W



 Table 3.
 Electrical Characteristics (TJ=25 ℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
On/Off Sta	On/Off States						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250µA	120			V	
IDSS	Zero Gate Voltage Drain Current	VDS=120V,VGS=0V			1	μA	
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA	
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250μA	1.2		2.2	V	
gFS	Forward Transconductance	VDS=5V,ID=15A		28		S	
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=20A		10	14	mΩ	
1100(011)	Brain course on state recipiante	VGS=4.5V, ID=15A		11	16	mΩ	
Dynamic (Characteristics						
Ciss	Input Capacitance	VDS=50V,VGS=0V,		2300		pF	
Coss	Output Capacitance	F=1MHZ		276		pF	
Crss	Reverse Transfer Capacitance			7.2		pF	
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz				Ω	
Switching	Times						
td(on)	Turn-on Delay Time			18		nS	
tr	Turn-on Rise Time	VGS=10V,VDS=50V,		5		nS	
td(off)	Turn-Off Delay Time	ID=25A,RGEN=2Ω		43		nS	
tf	Turn-Off Fall Time			6.3		nS	
Qg	Total Gate Charge			40		nC	
Qgs	Gate-Source Charge	VGS=10V, VDS=50V, ID=25A		7		nC	
Qgd	Gate-Drain Charge			8		nC	
Source-Drain Diode Characteristics							
ISD	Source-Drain Current(Body Diode)				60	А	
VSD	Forward on Voltage	VGS=0V,IS=20A			1.2	V	
trr	Reverse Recovery Time	IF=20A , dI/dt=100A/μs ,		79.5		ns	
Qrr	Reverse Recovery Charge	TJ=25℃		210		nc	
	·						

Notes 1. The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25 $^{\circ}\text{C}\text{,VDD}=50\text{V}\text{,Vgs}=10\text{V}$, ID=21A,L=0.5mH,RG=25ohm



■ Electrical Characteristics Diagrams

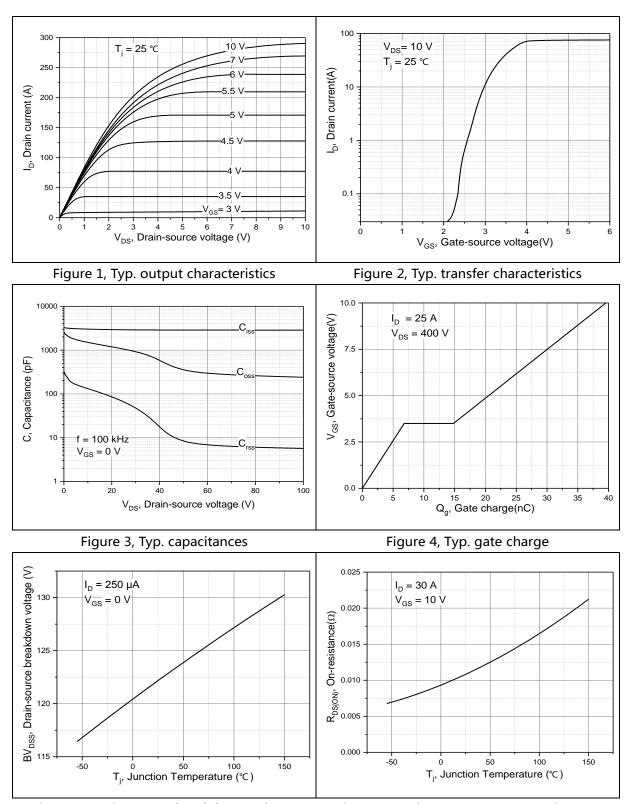


Figure 5, Drain-source breakdown voltage

Figure 6, Drain-source on-state resistance



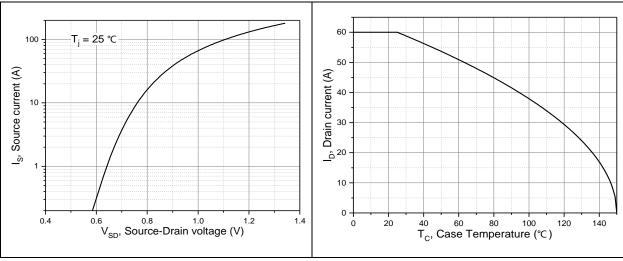


Figure 7, Forward characteristic of body diode

Figure 8, Drain current

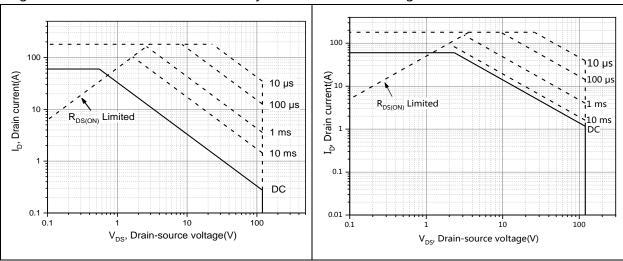


Figure 9, Safe operation area for TO220F T_C =25 °C

Figure 10, Safe operation area for TO220 T_C =25 $^{\circ}C$



■ Test circuits and waveforms

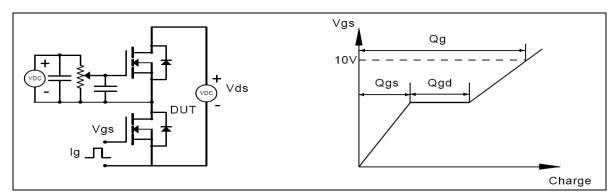


Figure 1, Gate charge test circuit & waveform

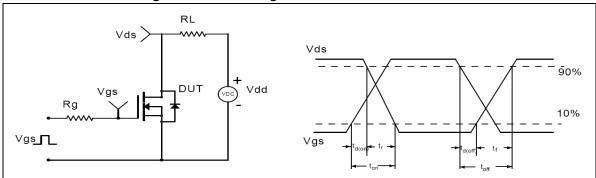


Figure 2, Switching time test circuit & waveforms

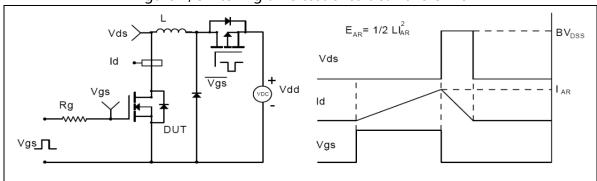


Figure 3, Unclamped inductive switching (UIS) test circuit & waveforms

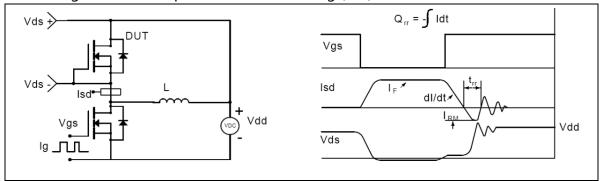
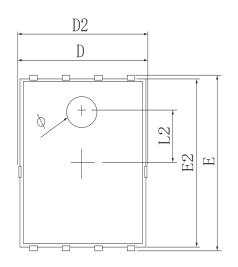
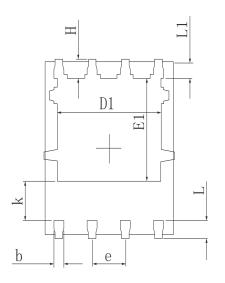


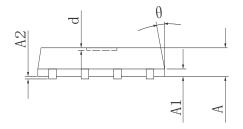
Figure 4, Diode reverse recovery test circuit & waveforms



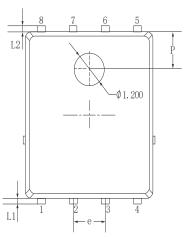
•Dimensions (PDFN5*6)

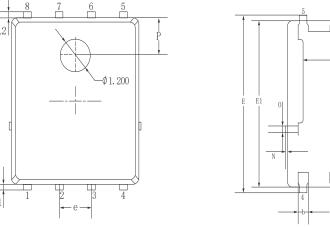


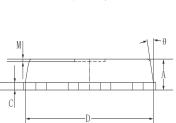




SYMBOL.		MILLIMETER		
SIMDUL	MIN	Typ.	MAX	
A	0.900	1.000	1.100	
A1		0.254 REF.		
A2		0~0.05		
D	4. 824	4.900	4.976	
D1	3.910	4.010	4.110	
D2	4. 924	5.000	5. 076	
Е	5. 924	6.000	6.076	
E1	3. 375	3. 475	3. 575	
E2	5. 674	5. 750	5. 826	
b	0.350	0.400	0.450	
е	1.270 TYP.			
L	0.534	0.610	0.686	
L1	0.424	0.500	0. 576	
L2	1.800 REF.			
k	1. 190	1. 290	1.390	
Н	0.549	0.625	0.701	
θ	8°	10°	12°	
Ф	1.100	1. 200	1.300	
d			0.100	





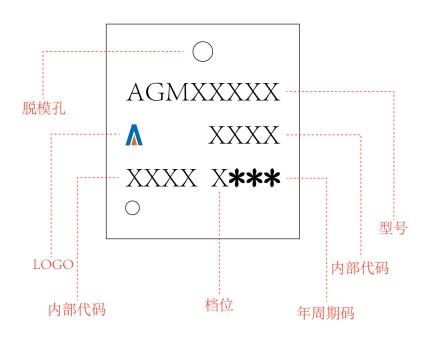


	Millimeters	
MIN.	NOM.	MAX.
0.90	1.05	1. 20
0.35	0.40	0.50
0.20	0. 25	0.35
4.90	5. 05	5. 20
3. 72	3. 82	3. 92
6.00	6. 15	6.30
5. 60	5. 75	5. 90
3. 47	3. 57	3. 67
	1.27 BSC.	
0.48	0.58	0.68
1. 17	1.27	1. 37
0.64	0.74	0.84
0.20 REF.		
8°	10°	12°
0.08 REF.		
0	-	0.15
0.25 REF.		
	1.28 REF.	
	MIN. 0. 90 0. 35 0. 20 4. 90 3. 72 6. 00 5. 60 3. 47 0. 48 1. 17 0. 64	0.90 1.05 0.35 0.40 0.20 0.25 4.90 5.05 3.72 3.82 6.00 6.15 5.60 5.75 3.47 3.57 1.27 BSC. 0.48 0.58 1.17 1.27 0.64 0.74 0.20 REF. 8° 10° 0.08 REF. 0 -

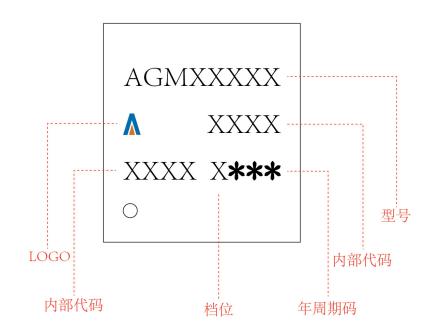


PDFN5*6 Marking Instructions:

Model1:



Model2:





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